Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination ASAO ET AL.	
10/635,611		
Examiner	Art Unit	
Tran N. Nguyen	2834	

SEARCHED .					
Class	Subclass	Date	Examiner		
310	216 254	6/20/	1		
336	212	1/07	IND		
	234	V	V		
29	596 -597 605 -60	9 6/21/07	DNW		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
29/596-598 605-609 336/212-234	E/21-)	
search of key words (recess concav\$3		/ <i>*\\)</i>		
notch groove void dent indentation depression cutout cavity)	4	D		
replate all ina	ge 10/10/ es 67	TN)	